

U.S. Department of Commerce Patent & Trademark Office Attorney Docket No. 218TG/48722

Serial No. 09/524,755

Applicant:

Peter HEINRICH et al.

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

Filing Date March 13, 2000 Group

U.S. PATENT DOCUMENTS											
Examiner Initial		Document Number	Date		Name	Class	Sub-Class	Filing Date (if appropriate)			
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		OTHER DOCU	MENTS (Incl	uding A	uthor, Title, Date, l	Pertinent Pag	es, etc.)				
SU	AQ	VII Finnish Conference on Physics in Industry, Nov. 1-2, 1995, Tampere, Finland entitled "Real-Time Optical Spray Pattern Diagnostics for Thermal Spraying" by T. Lehtinen et al.									
sce	AR	Proceedings of the XXX Annual Conference of the Finnish Physical Society entitled "In-Flight Particle Visualisation in Thermal Plasma Spraying Using an Intensified CCD Camera" by T. Lehtinen et al.									
scc	AS	Proceedings of the XXXI Annual Conference of the Finnish Physical Socient, March 13-15, 1997, Helsinki, Finland entitled "In-Flight Particle Concentration Measurements in Thermal Plasma Spraying Using a CCD Camera by T. Lehtinen et al.									
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Sce	AQ	Optics Day '97 - Proceedings Finnish Optical Society Tampere University of Technology, Feb. 21, 2997, Tampere, Finland entitled "Optical Spray Pattern Diagnostics for Thermal Spraying by T. Lehtinen et al.									
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